Search	h Notes	

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/615,621	HAN ET AL.	
Examiner	Art Unit	
Leah L. Richmond	2609	

SEARCHED			
Class	Subclass	Date	Examiner
370	389	3/9/2007	LLR
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST keyword search in USPAT, USPGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB (see attached search strategy)	03/06/2007	LLR
Inventor name and Assignee search in PALM ExPO	3/5/2007	LLR
Google Search	3/6/2007	LLR
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